


[Home](#) | [Login](#) | [Logout](#) | [Access Information](#) | [Alerts](#) |

Welcome United States Patent and Trademark Office

 Search Results**BROWSE****SEARCH****IEEE XPLORE GUIDE**

Results for "((((sensor<in>metadata))<and>(mode<in>metadata)))<and>(resolution<in>..."

 e-mail

Your search matched 346 of 3542 documents.

A maximum of 100 results are displayed, 25 to a page, sorted by **Relevance in Descending order**.» **Search Options**[View Session History](#)[New Search](#)**Modify Search**

» **Key**

IEEE JNL IEEE Journal or Magazine

[Select All](#) [Deselect All](#)View: [1-25](#) | [26-5](#)

IET JNL IET Journal or Magazine

- 1. A new high-resolution 11-mm diagonal image sensor for still-picture phot**
 Hynecek, J.;
Electron Devices, IEEE Transactions on
 Volume 36, Issue 11, Part 2, Nov 1989 Page(s):2466 - 2474
 Digital Object Identifier 10.1109/16.43669

IEEE CNF IEEE Conference Proceeding

[AbstractPlus](#) | [Full Text: PDF\(1093 KB\)](#) IEEE JNL
[Rights and Permissions](#)

IET CNF IET Conference Proceeding

- 2. Efficient fiber Bragg grating and fiber fabry-Pe/spl acute/rot sensor multi**
 using a broadband pulsed mode-locked laser
 Cranch, G.A.; Flockhart, G.M.H.; Kirkendall, C.K.;
Lightwave Technology, Journal of
 Volume 23, Issue 11, Nov. 2005 Page(s):3798 - 3807
 Digital Object Identifier 10.1109/JLT.2005.857735

[AbstractPlus](#) | [Full Text: PDF\(648 KB\)](#) IEEE JNL
[Rights and Permissions](#)

IEEE STD IEEE Standard

- 3. On-focal-plane signal processing for current-mode active pixel sensors**
 Nakamura, J.; Pain, B.; Nomoto, T.; Nakamura, T.; Fossum, E.R.;
Electron Devices, IEEE Transactions on
 Volume 44, Issue 10, Oct. 1997 Page(s):1747 - 1758
 Digital Object Identifier 10.1109/16.628832

[AbstractPlus](#) | [References](#) | [Full Text: PDF\(276 KB\)](#) IEEE JNL
[Rights and Permissions](#)

- 4. A 4 M-Pixel CMOS image sensor with block and skip access capability**
 Nomoto, T.; Hosokai, S.; Isokawa, T.; Hyuga, R.; Nakajima, S.; Terada, T.;
Electron Devices, IEEE Transactions on
 Volume 44, Issue 10, Oct. 1997 Page(s):1738 - 1746
 Digital Object Identifier 10.1109/16.628831

[AbstractPlus](#) | [References](#) | [Full Text: PDF\(204 KB\)](#) IEEE JNL
[Rights and Permissions](#)

- 5. Feasibility study of online high-spatial-resolution MOSFET dosimetry in s**
 x-ray radiation fields
 Rosenfeld, A.B.; Lerch, M.L.F.; Kron, T.; Brauer-Krisch, E.; Bravin, A.; Holmes-B.J.;
Nuclear Science, IEEE Transactions on